

# Y Precision, High Speed, JFET Input Operational Amplifiers

#### **FEATURES**

■ Guaranteed Offset Voltage	150μV Max
-55°C to 125°C	500μV Max
■ Guaranteed Drift	4μV/°C Max
■ Guaranteed Bias Current	
70°C	150pA Max
125°C	2.5nA Max
■ Guaranteed Slew Rate	12V/μs Min

### **APPLICATIONS**

- Precision, High Speed Instrumentation
- Logarithmic Amplifiers
- D/A Output Amplifiers
- Photodiode Amplifiers
- Voltage-to-Frequency Converters
- Frequency-to-Voltage Converters
- Fast, Precision Sample-and-Hold

#### **DESCRIPTION**

The LT1055/LT1056 JFET input operational amplifiers combine precision specifications with high speed performance.

For the first time,  $16V/\mu s$  slew rate and 6.5MHz gain-banwidth product are simultaneously achieved with offset voltage of typically  $50\mu V$ ,  $1.2\mu V/^{\circ}C$  drift, bias currents of 40pA at  $70^{\circ}C$  and 500pA at  $125^{\circ}C$ .

The  $150\mu V$  maximum offset voltage specification is the best available on any JFET input operational amplifier.

The LT1055 and LT1056 are differentiated by their operating currents. The lower power dissipation LT1055 achieves lower bias and offset currents and offset voltage. The additional power dissipation of the LT1056 permits higher slew rate, bandwidth and faster settling time with a slight sacrifice in DC performance.

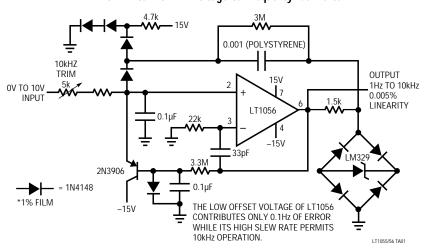
The voltage-to-frequency converter shown below is one of the many applications which utilize both the precision and high speed of the LT1055/LT1056.

For a JFET input op amp with 23V/µs guaranteed slew rate, refer to the LT1022 data sheet.

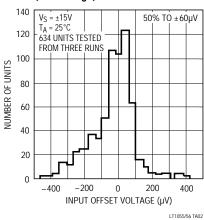
■ T and LTC are registered trademarks and LT is a trademark of Linear Technology Corporation.

### TYPICAL APPLICATION

OkHz to 10kHz Voltage-to-Frequency Converter



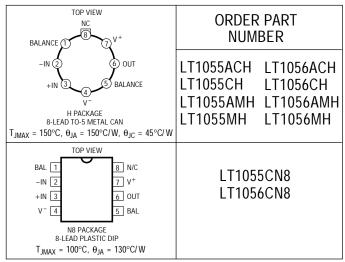
# Distribution of Input Offset Voltage (H Package)



# **ABSOLUTE MAXIMUM RATINGS**

Supply Voltage±20V
Differential Input Voltage±40V
Input Voltage±20V
Output Short-Circuit DurationIndefinite
Operating Temperature Range
LT1055AM/LT1055M/LT1056AM/
LT1056M55°C to 125°C
LT1055AC/LT1055C/LT1056AC/
LT1056C 0°C to 70°C
Storage Temperature Range
All Devices –65°C to 150°C
Lead Temperature (Soldering, 10 sec)300°C

# PACKAGE/ORDER INFORMATION



Consult factory for Industrial grade parts.

# **ELECTRICAL CHARACTERISTICS** $V_S = \pm 15V$ , $T_A = 25^{\circ}C$ , $V_{CM} = 0V$ unless otherwise noted.

					55AM/LT10 55AC/LT10		LT10 LT10! LT105!			
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNITS	
$\overline{V_{OS}}$	Input Offset Voltage (Note1)	LT1055 H Packag	е	_	50	150	_	70	400	μV
		LT1056 H Packag		_	50	180	_	70	450	μV
		LT1055 N8 Packa		_	_	_	_	120	700	μV
		LT1056 N8 Packa	ge	_			_	140	800	μV
los	Input Offset Current	Fully Warmed Up		_	2	10	_	2	20	pA
$I_B$	Input Bias Current	Fully Warmed Up		_	±10	±50	_	±10	±50	pA
		$V_{CM} = 10V$		_	30	130	_	30	150	pA
	Input Resistance: Differential			_	10 <sup>12</sup>	_	_	10 <sup>12</sup>	_	Ω
	Common Mode	$V_{CM} = -11V \text{ to } 8V$	/	_	10 <sup>12</sup> 10 <sup>11</sup>	_	_	10 <sup>12</sup> 10 <sup>11</sup>	_	Ω
	Input Capacitance	$V_{CM} = 8V \text{ to } 11V$		_	4	_	_	4	_	Ω
	Input Noise Voltage	0.1Hz to 10Hz	 _T1055		1.8		_	2.0		pF
e <sub>n</sub>	Input Noise Voltage		_T1055 _T1056	_ _	2.5	_	_ _	2.0	_	μV <sub>P-P</sub> μV <sub>P-P</sub>
	Input Noice Voltage Density				2.3	50		30	60	nV/√Hz
	Input Noise Voltage Density	$f_0 = 10$ Hz (Note 2 $f_0 = 1$ kHz (Note 3	,	_	28 14	20	_ _	30 15	22	$nV/\sqrt{Hz}$
In	Input Noise Current Density	$f_0 = 10Hz, 1kHz$ (	<u> </u>	_	1.8	4	_	1.8	4	fA/√Hz
A <sub>VOL</sub>	Large-Signal Voltage Gain		$R_1 = 2k$	150	400		120	400		V/mV
AVOL	Large-Signal Voltage Gain		$R_L = 1k$	130	300	_	100	300	_	V/mV
	Input Voltage Range	•	KL - IK	±11	±12		±11	±12	_	V
CMRR	Common-Mode Rejection Ratio	V <sub>CM</sub> = ±11V		86	100		83	98		dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 10V \text{ to } \pm 18$	BV	90	106	_	88	104	_	dB
V <sub>OUT</sub>	Output Voltage Swing	$R_L = 2k$		±12	±13.2	_	±12	±13.2	_	V
SR	Slew Rate	I	_T1055	10	13	_	7.5	12	_	V/µs
		I	_T1056	12	16	_	9.0	14	_	V/μs
GBW	Gain-Bandwidth Product	f = 1MHz	_T1055	_	5.0	_	_	4.5	_	MHz
		I	_T1056	_	6.5	_	_	5.5	_	MHz
Is	Supply Current	[	_T1055	_	2.8	4.0	_	2.8	4.0	mA
		l I	_T1056	_	5.0	6.5	_	5.0	7.0	m A
	Offset Voltage Adjustment Range	$R_{POT} = 100k$		_	±5	_	_	±5	_	m V

# **ELECTRICAL CHARACTERISTICS** $V_S = \pm 15 V, \ V_{CM} = 0 V, \ 0^{\circ} C \le T_A \le 70^{\circ} C$ unless otherwise noted.

		CONDITIONS MI			LT1055AC LT1056AC			LT1055CH/LT1056CH LT1055CN8/LT1056CN8		
SYMBOL	PARAMETER				TYP	MAX	MIN	TYP	MAX	UNITS
$V_{OS}$	Input Offset Voltage (Note1)	LT1055 H Package	•	_	100	330	_	140	750	μV
		LT1056 H Package	•	_	100	360	_	140	800	μV
		LT1055 N8 Package	•	_	_	_	_	250	1250	μV
		LT1056 N8 Package	•	_	_	_	_	280	1350	μV
	Average Temperature	H Package (Note 5)	•	_	1.2	4.0	_	1.6	8.0	μV/°C
	Coefficient of Input Offset Voltage	N8 Package (Note 5)	•	_	_	_	_	3.0	12.0	μV/°C
los	Input Offset Current	Warmed Up LT1055	•	_	10	50	_	16	80	pA
		$T_A = 70^{\circ}C$ LT1056	•	_	14	70	_	18	100	pA
I <sub>B</sub>	Input Bias Current	Warmed Up LT1055	•	_	±30	±150	_	±40	±200	pA
		$T_A = 70^{\circ}C$ LT1056	•	_	±40	±80	_	±50	±240	pA
A <sub>VOL</sub>	Large-Signal Voltage Gain	$V_0 = \pm 10V, R_L = 2k$		80	250	_	60	250	_	V/mV
CMRR	Common-Mode Rejection Ratio	V <sub>Cm</sub> = ±10.5V		85	100	_	82	98	_	dB
PSRR	Power Supply Rejection Ratio	V <sub>S</sub> = ±10V to ±18V  ■		89	105	_	87	103	_	dB
V <sub>OUT</sub>	Output Voltage Swing	$R_L = 2k$	•	±12	±13.1	_	±12	±13.1	_	V

#### $V_S$ = $\pm 15 V,~V_{CM}$ = $0 V,~-55^{\circ} C \leq T_A \leq 125^{\circ} C$ unless otherwise noted.

		CONDITIONS			LT1055AM LT1056AM			LT1055M LT1056M			
SYMBOL	PARAMETER				MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Vos	Input Offset Voltage (Note1)		LT1055	•	_	180	500	_	250	1200	μV
			LT1056	•	_	180	550	_	250	1250	μV
	Average Temperature Coefficient of Input Offset Voltage	(Note 5)		•	_	1.3	4.0	_	1.8	8.0	μV/°C
$I_{OS}$	Input Offset Current	Warmed Up	LT1055	•	-	0.20	1.2	_	0.25	1.8	nA
		T <sub>A</sub> = 125°C	LT1056	•	_	0.25	1.5	_	0.30	2.4	nA
I <sub>B</sub>	Input Bias Current	Warmed Up	LT1055	•	_	±0.4	±2.5	_	±0.5	±4.0	nA
		T <sub>A</sub> = 125°C	LT1056	•	_	±0.5	±3.0	_	±0.6	±5.0	nA
A <sub>VOL</sub>	Large-Signal Voltage Gain	$V_0 = \pm 10V, R_L = 2k$		•	40	120	_	35	120	_	V/mV
CMRR	Common-Mode Rejection Ratio	$V_{CM} = \pm 10.5V$		•	85	100	_	82	98	_	dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 10V$ to $\pm$	17V	•	88	104	_	86	102	_	dB
V <sub>OUT</sub>	Output Voltage Swing	R <sub>L</sub> = 2k		•	±12	±12.9	_	±12	±12.9	_	V

The lacktriangle denotes specifications which apply over the full operating temperature range.

**Note 1:** Offset voltage is measured under two different conditions: (a) approximately 0.5 seconds after application of power; (b) at  $T_A = 25^{\circ}C$  only, with the chip heated to approximately 38°C for the LT1055 and to 45°C for the LT1056, to account for chip temperature rise when the device is fully warmed up.

Note 2: 10Hz noise voltage density is sample tested on every lot of A grades. Devices 100% tested at 10Hz are available on request.

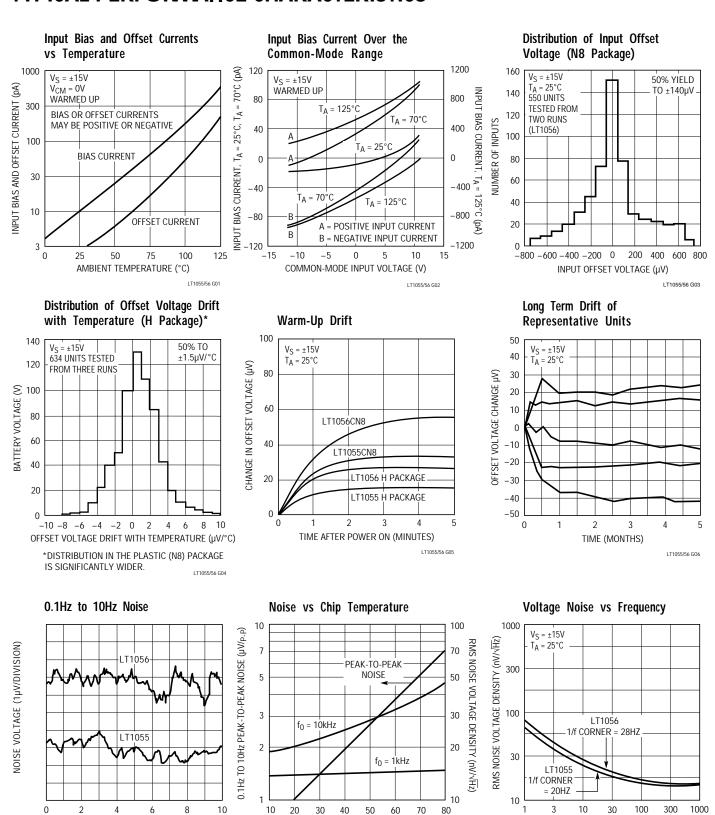
Note 3: This parameter is tested on a sample basis only.

**Note 4:** Current noise is calculated from the formula:  $i_n=(2ql_B)^{1/2}$ , where  $q=1.6\times 10^{-19}$  coulomb. The noise of source resistors up to  $1G\Omega$  swamps the contribution of current noise.

Note 5: Offset voltage drift with temperature is practically unchanged when the offset voltage is trimmed to zero with a 100k potentiometer between the balance terminals and the wiper tied to  $V^{+}$ . Devices tested to tighter drift specifications are available on request.



## TYPICAL PERFORMANCE CHARACTERISTICS



CHIP TEMPERATURE (°C)

LT1055/56 G08



LT1055/56 G09

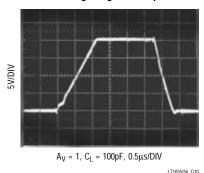
FREQUENCY (Hz)

TIME (SECONDS)

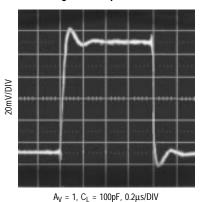
LT1055/56 GO7

# TYPICAL PERFORMANCE CHARACTERISTICS

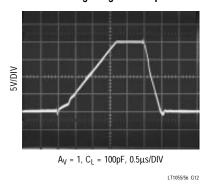
LT1056 Large-Signal Response



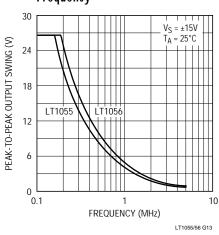
Small-Signal Response



LT1055 Large-Signal Response

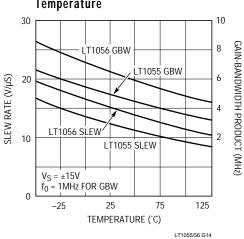


Undistorted Output Swing vs Frequency

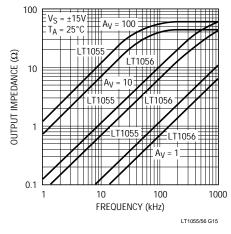


Slew Rate, Gain-Bandwidth vs Temperature

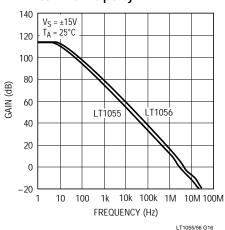
LT1055/56 G11



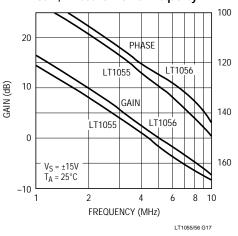
Output Impedence vs Frequency



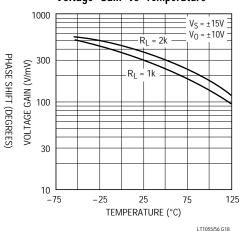
Gain vs Frequency



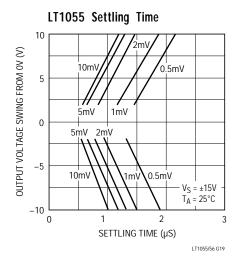
Gain, Phase Shift vs Frequency

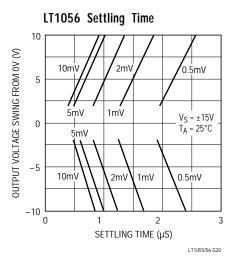


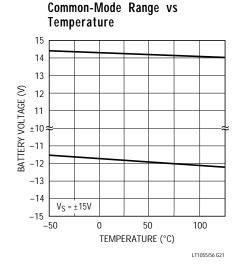
Voltage Gain vs Temperature



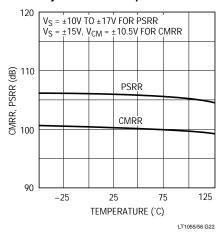
# TYPICAL PERFORMANCE CHARACTERISTICS



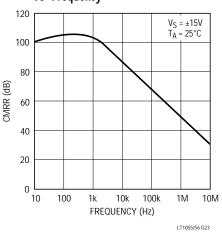




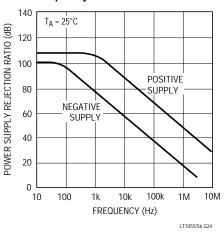




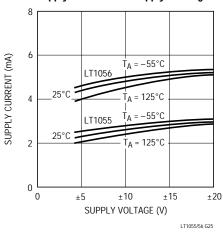




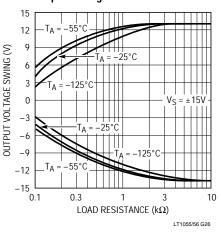
Power Supply Rejection Ratio vs Frequency



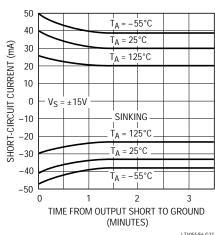
#### Supply Current vs Supply Voltage







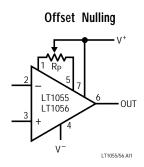
Short-Circuit Current vs Time



LT1055/56 G2

#### APPLICATIONS INFORMATION

The LT1055/LT1056 may be inserted directly into LF155A/LT355A, LF156A/LT356A, OP-15 and OP-16 sockets. Offset nulling will be compatible with these devices with the wiper of the potentiometer tied to the positive supply.



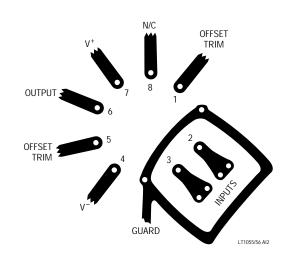
No appreciable change in offset voltage drift with temperature will occur when the device is nulled with a potentiometer,  $R_{\text{P}}$ , ranging from 10k to 200k.

The LT1055/LT1056 can also be used in LF351, LF411, AD547, AD611, OPA-111, and TL081 sockets, provided that the nulling cicuitry is removed. Because of the LT1055/LT1056's low offset voltage, nulling will not be necessary in most applications.

#### Achieving Picoampere/Microvolt Performance

In order to realize the picoampere-microvolt level accuracy of the LT1055/LT1056 proper care must be exercised. For example, leakage currents in circuitry external to the op amp can significantly degrade performance. High quality insulation should be used (e.g. Teflon™, Kel-F); cleaning of all insulating surfaces to remove fluxes and other residues will probably be required. Surface coating may be necessary to provide a moisture barrier in high humidity environments.

Board leakage can be minimized by encircling the input circuitry with a guard ring operated at a potential close to that of the inputs: in inverting configurations the guard ring should be tied to ground, in noninverting connnections to the inverting input at pin 2. Guarding both sides of the printed circuit board is required. Bulk leakage reduction depends on the guard ring width.



The LT1055/LT1056 has the lowest offset voltage of any JFET input op amp available today. However, the offset voltage and its drift with time and temperature are still not as good as on the best bipolar amplifiers because the transconductance of FETs is considerably lower than that of bipolar transistors. Conversely, this lower transconductance is the main cause of the significantly faster speed performance of FET input op amps.

Offset voltage also changes somewhat with temperature cycling. The AM grades show a typical  $20\mu V$  hysteresis (30 $\mu V$  on the M grades) when cycled over the  $-55^{\circ}C$  to 125°C temperature range. Temperature cycling from 0°C to 70°C has a negligible (less than  $10\mu V)$  hysteresis effect.

The offset voltage and drift performance are also affected by packaging. In the plastic N8 package the molding compound is in direct contact with the chip, exerting pressure on the surface. While NPN input transistors are largely unaffected by this pressure, JFET device matching and drift are degraded. Consequently, for best DC performance, as shown in the typical performance distribution plots, the TO-5 H package is recommended.

#### Noise Performance

The current noise of the LT1055/LT1056 is practically immeasurable at 1.8fA/ $\sqrt{Hz}$ . At 25°C it is negligible up to 1G of source resistance, R<sub>S</sub> (compound to the noise of R<sub>S</sub>). Even at 125°C it is negligible to 100M of R<sub>S</sub>.

Teflon is a trademark of Dupont.



### APPLICATIONS INFORMATION

The voltage noise spectrum is characterized by a low 1/f corner in the 20Hz to 30Hz range, significantly lower than on other competitive JFET input op amps. Of particular interest is the fact that with any JFET IC amplifier, the frequency location of the 1/f corner is proportional to the square root of the internal gate leakage currents and, therefore, noise doubles every  $20^{\circ}$ C. Furthermore, as illustrated in the noise versus chip temperature curves, the 0.1Hz to 10Hz peak-to-peak noise is a strong function of temperature, while wideband noise ( $f_0 = 1$ kHz) is practically unaffected by temperature.

Consequently, for optimum low frequency noise, chip temperature should be minimized. For example, operating an LT1056 at  $\pm 5V$  supplies or with a 20°C/W case-to-ambient heat sink reduces 0.1Hz to 10Hz noise from typically 2.5 $\mu$ V<sub>P-P</sub> ( $\pm 15V$ , free-air) to 1.5 $\mu$ V<sub>P-P</sub>. Similiarly, the noise of an LT1055 will be 1.8 $\mu$ V<sub>P-P</sub> typically because of its lower power dissipation and chip temperature.

#### **High Speed Operation**

Settling time is measured in the test circuit shown. This test configuration has two features which eliminate problems common to settling time measurments: (1) probe

10μF

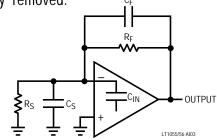
SOLID TANTALUM

0.01 DISC

capacitance is isolated from the "false summing" node, and (2) it does not require a "flat top" input pulse since the input pulse is merely used to steer current through the diode bridges. For more details, please see Application Note 10.

As with most high speed amplifiers, care should be taken with supply decoupling, lead dress and component placement.

When the feedback around the op amp is resistive ( $R_F$ ), a pole will be created with  $R_F$ , the source resistance and capacitance ( $R_S$ ,  $R_S$ ), and the amplifier input capacitance ( $R_S$ ,  $R_S$ ). In low closed-loop gain configurations and with  $R_S$  and  $R_F$  in the kilohm range, this pole can create excess phase shift and even oscillation. A small capacitor ( $R_S$ ) in parallel with  $R_S$  eliminates this problem. With  $R_S$  ( $R_S$ ) in parallel with  $R_S$  eliminates this problem. With  $R_S$  ( $R_S$ ) in parallel with  $R_S$ 0 in parallel with  $R_S$ 1 in the effect of the feedback pole is completely removed.



-15V

#### 10pF (TYPICAL) 15V 10µF 0.01 DISC SOLID TANTALUN LT1055 **AUT OUTPUT** LT1056 10μF AMPLIFIER 0.01 DISC SOLID **≥**10k UNDER 2N3866 TANTALUM 15V TEST 2N160 1/2 PULSE GEN U440 **≨**3Ω HP5082-8210 INPUT **HEWLETT** (5V MIN STEP) 10μF -15V **≥**50Ω OUTPUT **PACKARD** 0.01 DISC SOLID TO SCOPE 15V TANTALUM 30 1/2 U440 2N3866 **1**00Ω 2N5160 DC ZERO

= 1N4148

Settling Time Test Circuit

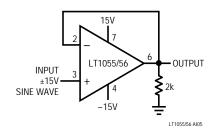
LT1055/56 AI04

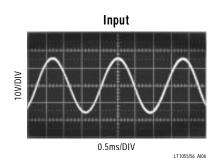
## APPLICATIONS INFORMATION

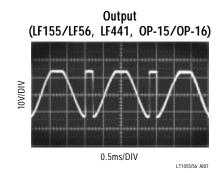
#### Phase Reversal Protection

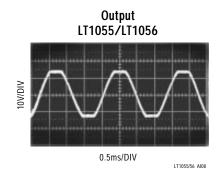
Most industry standard JFET input op amps (e.g., LF155/LF156, LF351, LF411, OP15/16) exhibit phase reversal at the output when the negitive common-mode limit at the input is exceeded (i.e., from -12V to -15V with  $\pm 15V$  supplies). This can cause lock-up in servo systems. As shown below, the LT1055/LT1056 does not have this problem due to unique phase reversal protection circuitry (Q1 on simplified schematic).

Voltage Follower with Input Exceeding the Negative Common-Mode Range



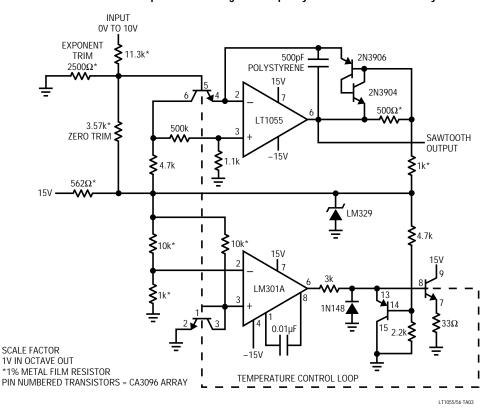






# TYPICAL APPLICATIONS †

#### Exponential Voltage-to-Frequency Converter for Music Synthesizers

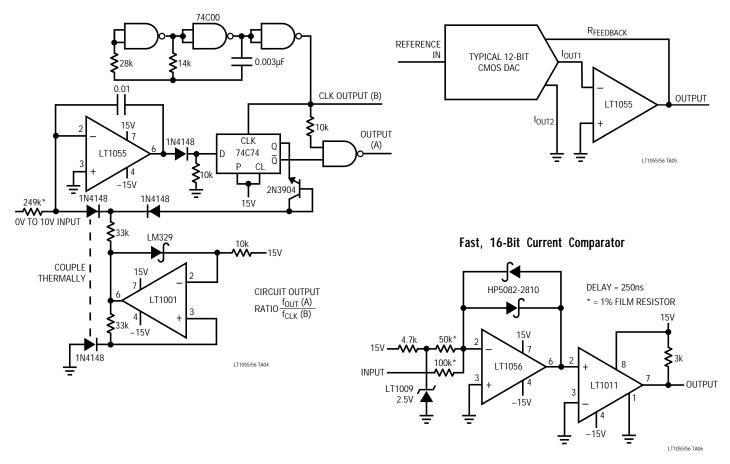


<sup>†</sup>For ten additional applications utilizing the LT1055 and LT1056, please see the LTC1043 data sheet and Application Note 3.

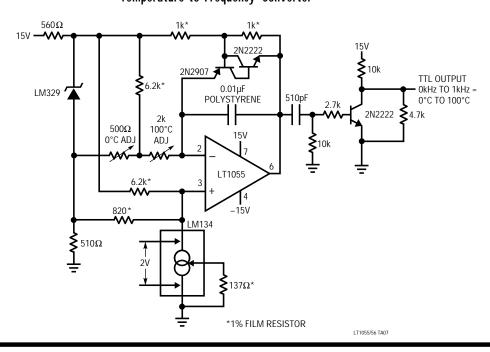
## TYPICAL APPLICATIONS

12-Bit Charge Balance A/D Converter

Fast "No Trims" 12-Bit Multiplying CMOS DAC Amplifier

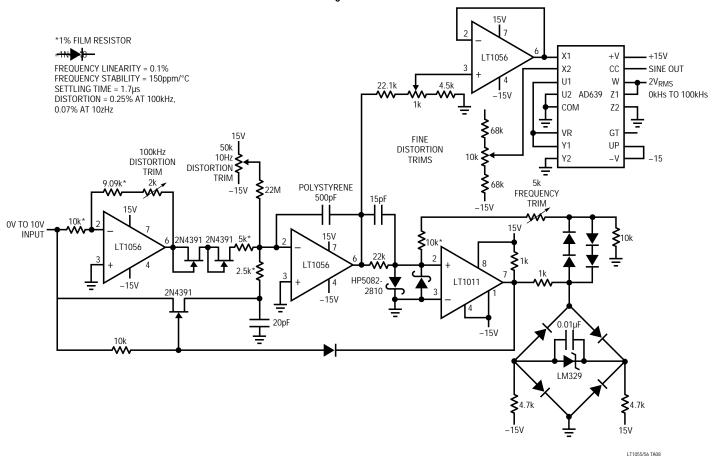


#### Temperature-to-Frequency Converter



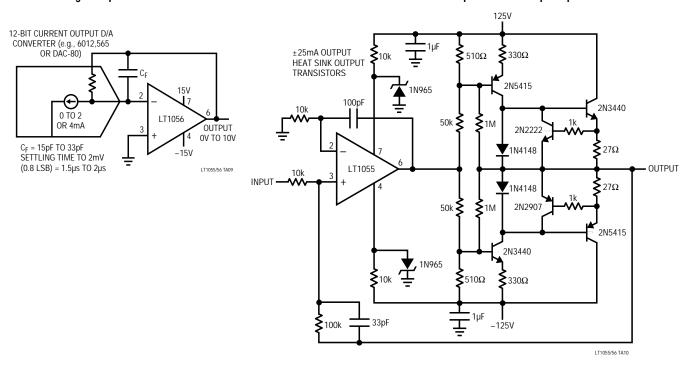
## TYPICAL APPLICATIONS

#### 100kHz Voltage Controlled Oscillator

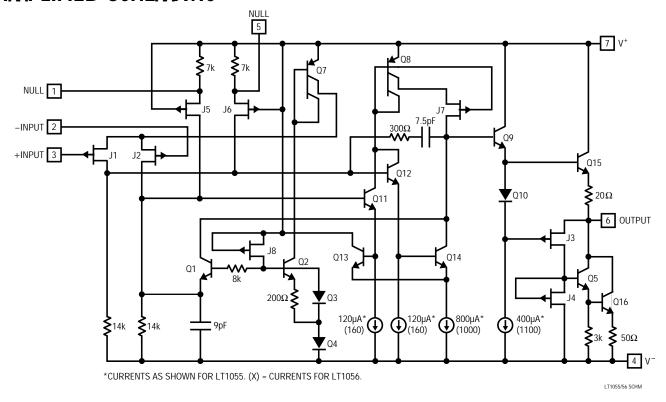


#### 12-Bit Voltage Output D/A Converter

#### ±120V Output Precision Op Amp



## SIMPLIFIED SCHEMATIC



## PACKAGE DESCRIPTION

Dimension in inches (millimeters) unless otherwise noted.

